NSN 6625-01-317-6995

Electronic Systems Test Set - Page 1 of 1



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Test	Type	For	Which	Desig	ned:
1631	IVDE	1 01	VVIIICII	DESIG	HEU.

Digital device functional testingand analog circuitry performance testing

Shelf Life:

N/a

Unit Of Measure:

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Demilitarization:

No

Fiig:

T228-a